

60 V, 6.2 A NPN low V_{CEsat} (BISS) transistor Rev. 01 — 1 April 2010

Product data sheet

1. **Product profile**

1.1 General description

NPN low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a medium power and flat lead SOT89 (SC-62) Surface-Mounted Device (SMD) plastic package.

PNP complement: PBSS4041PX.

1.2 Features and benefits

- Very low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High energy efficiency due to less heat generation
- AEC-Q101 qualified
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- Loadswitch
- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

1.4 Quick reference data

Table 1. **Quick reference data**

Symbol	Parameter	Conditions	Min	Tun	Max	Unit
Symbol	Farameter	Conditions	IVIIII	Тур	wax	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	60	V
I _C	collector current		-	-	6.2	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 ms$	-	-	15	A
R _{CEsat}	collector-emitter saturation resistance	l _C = 4 A; l _B = 400 mA	<u>[1]</u> _	25	35	mΩ

[1] Pulse test: $t_p \le 300 \ \mu s$; $\delta \le 0.02$.



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2. Pinning information

Table 2.	Pinning		
Pin	Description	Simplified outline	Graphic symbol
1	emitter	_	
2	collector		2 J
3	base		3

3. Ordering information

Table 3. Order	ing inform	ation	
Type number	Package		
	Name	Description	Version
PBSS4041NX	SC-62	plastic surface-mounted package; 3 leads	SOT89

4. Marking

Table 4. Marking codes	
Type number	Marking code ^[1]
PBSS4041NX	*6F
[1] * = -: made in Hong Kong	

- * = p: made in Hong Kong
- * = t: made in Malaysia
- * = W: made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CBO}	collector-base voltage	open emitter	-	60	V
V _{CEO}	collector-emitter voltage	open base	-	60	V
V _{EBO}	emitter-base voltage	open collector	-	5	V
I _C	collector current		-	6.2	А
I _{CM}	peak collector current	single pulse; $t_p \leq 1 \ ms$	-	15	A
I _B	base current		-	1	А

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Table 5.	Limiting	values	continued
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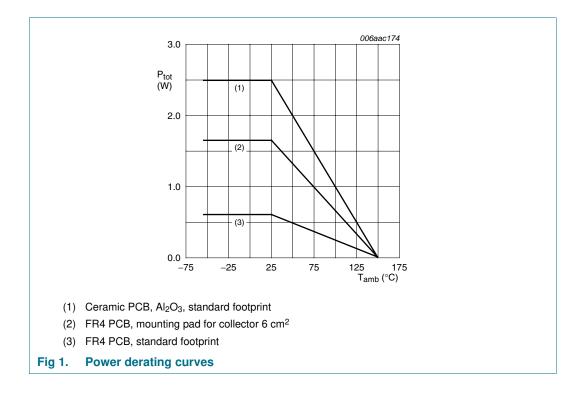
In accordance with the Absolute Maximum Rating System (IEC 60134).

Parameter	Conditions		Min	Max	Unit
total power dissipation	$T_{amb} \le 25 \ ^{\circ}C$	[1]	-	600	mW
		[2]	-	1650	mW
		[3]	-	2500	mW
junction temperature			-	150	°C
ambient temperature			-55	+150	°C
storage temperature			-65	+150	°C
	total power dissipation junction temperature ambient temperature	total power dissipation $T_{amb} \le 25 \text{ °C}$ junction temperature ambient temperature	total power dissipation $T_{amb} \le 25 \text{ °C}$ [1] [2] [3] junction temperature ambient temperature	total power dissipation $T_{amb} \le 25 \text{ °C}$ $\begin{bmatrix} 11 & - & & \\ & 2 & - & \\ & & & 3 & - \\ \hline & & & & & \\ ambient temperature & & & -55 \end{bmatrix}$	total power dissipation $T_{amb} \le 25 \text{ °C}$ [1] - 600 [2] - 1650 [3] - 2500 junction temperature - 150 ambient temperature -55 +150

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

[3] Device mounted on a ceramic PCB, AI_2O_3 , standard footprint.



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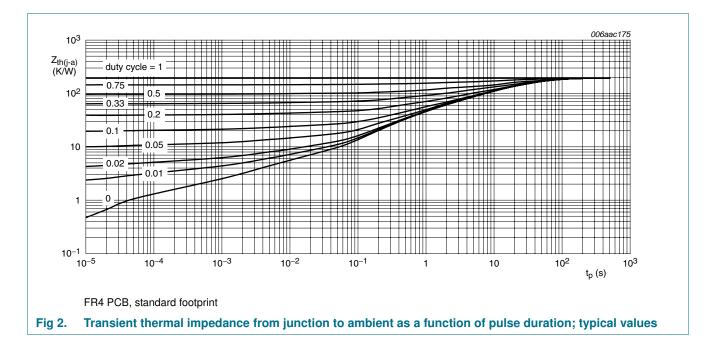
6. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
(ing-a)	thermal resistance from	in free air	<u>[1]</u> -	-	210	K/W
	junction to ambient		[2] _	-	75	K/W
			<u>[3]</u> _	-	50	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	20	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².

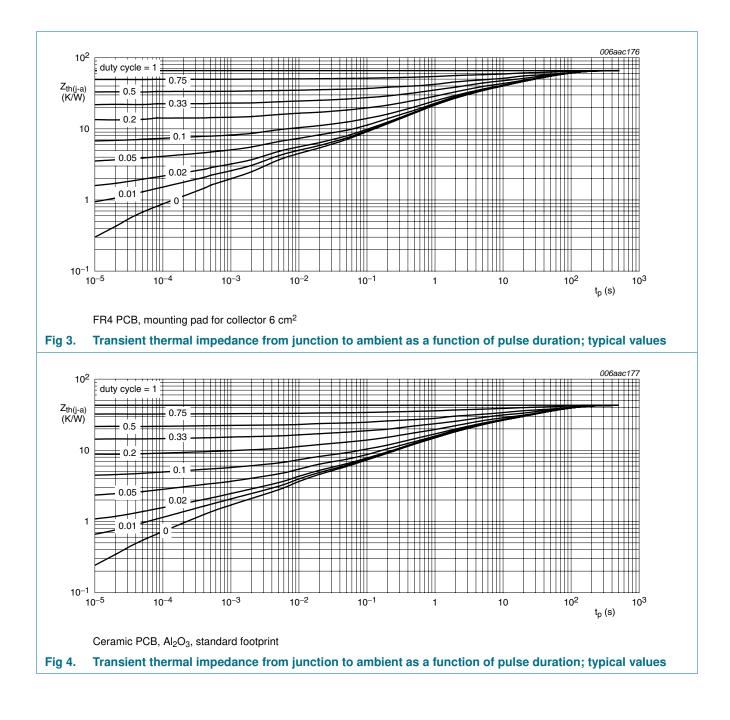
[3] Device mounted on a ceramic PCB, AI_2O_3 , standard footprint.



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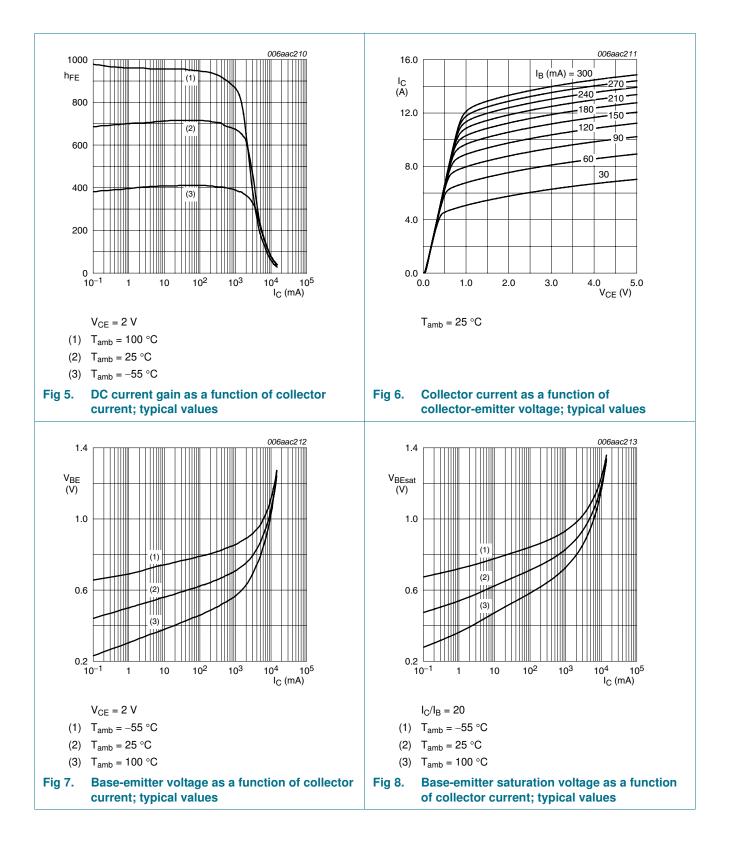
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7. Characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = 60 \text{ V}; I_E = 0 \text{ A}$		-	-	100	nA
	current	$V_{CB} = 60 \text{ V}; I_E = 0 \text{ A};$ T _j = 150 °C		-	-	50	μA
I _{CES}	collector-emitter cut-off current	$V_{CE} = 48 \text{ V}; V_{BE} = 0 \text{ V}$		-	-	100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; \text{ I}_{C} = 0 \text{ A}$		-	-	100	nA
h _{FE} DC current gain		$V_{CE} = 2 V$	[1]				
		I _C = 500 mA		300	500	-	
		$I_{\rm C} = 1 \rm A$		300	500	-	
		I _C = 2 A		250	450	-	
		$I_{\rm C} = 4$ A		150	250	-	
		I _C = 6 A		75	120	-	
V _{CEsat}	collector-emitter		[1]				
	saturation voltage	$I_{C} = 1 \text{ A}; I_{B} = 50 \text{ mA}$		-	35	50	mV
		$I_{C} = 1 \text{ A}; I_{B} = 10 \text{ mA}$		-	50	80	mV
		$I_{C} = 2 \text{ A}; I_{B} = 40 \text{ mA}$		-	95	145	mV
		$I_{C} = 4 \text{ A}; I_{B} = 200 \text{ mA}$		-	110	150	mV
		$I_{C} = 4 \text{ A}; I_{B} = 40 \text{ mA}$		-	240	320	mV
		$I_{C} = 6 \text{ A}; I_{B} = 300 \text{ mA}$		-	150	210	mV
R _{CEsat}	collector-emitter saturation resistance	$I_{C} = 4 \text{ A}; I_{B} = 400 \text{ mA}$	[1]	-	25	35	mΩ
V _{BEsat}	base-emitter	$I_{C} = 1 \text{ A}; I_{B} = 100 \text{ mA}$	[1]	-	0.82	0.9	V
	saturation voltage	$I_{C} = 4 \text{ A}; I_{B} = 400 \text{ mA}$	[1]	-	0.92	1.05	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	<u>[1]</u>	-	0.75	0.85	V
t _d	delay time	$V_{CC} = 12.5 \text{ V}; \text{ I}_{C} = 1 \text{ A};$		-	35	-	ns
t _r	rise time	$I_{Bon} = 0.05 \text{ A};$		-	65	-	ns
t _{on}	turn-on time	$I_{Boff} = -0.05 \text{ A}$		-	100	-	ns
t _s	storage time			-	1050	-	ns
t _f	fall time			-	220	-	ns
t _{off}	turn-off time			-	1270	-	ns
f _T	transition frequency	V _{CE} = 10 V; I _C = 100 mA; f = 100 MHz		-	130	-	MHz
C _c	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz		-	35	-	pF

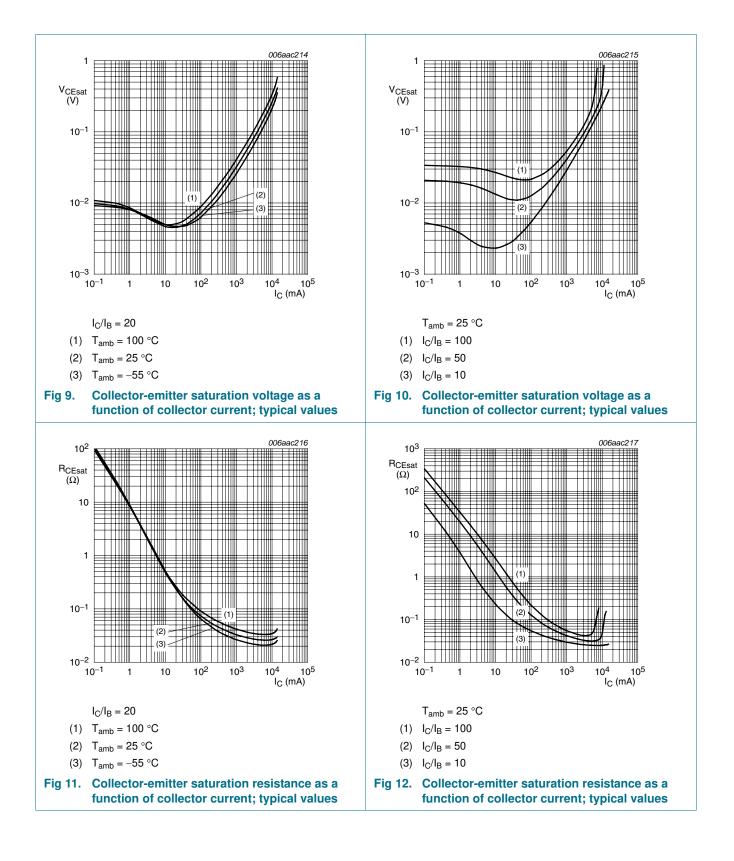
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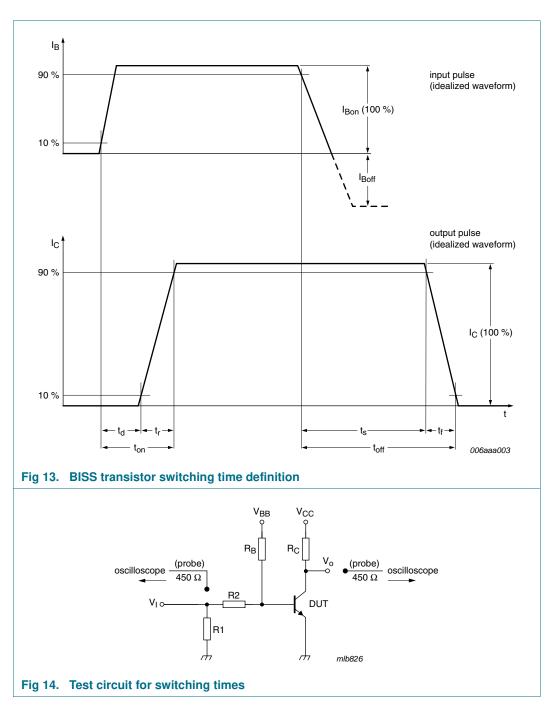
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8. Test information

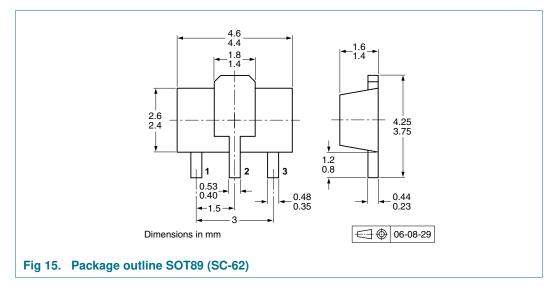


8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101* - *Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

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9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

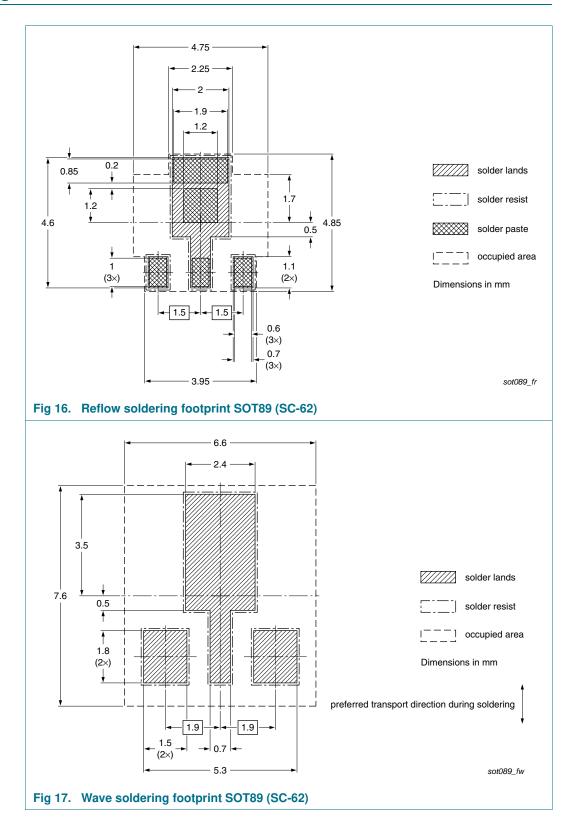
Type number Package Description			Packing	quantity	
				3000	10000
PBSS4041NX	SOT89	8 mm pitch, 12 mm tape and reel; T1	[2]	-115	-135
		8 mm pitch, 12 mm tape and reel; T3	[3]	-120	-

[1] For further information and the availability of packing methods, see <u>Section 14</u>.

- [2] T1: normal taping
- [3] T3: 90° rotated taping

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11. Soldering



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12. Revision history

Table 9. Revision hist	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS4041NX_1	20100401	Product data sheet	-	-

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13. Legal information

13.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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14. Contact information

For more information, please visit: <u>http://www.nxp.com</u>

For sales office addresses, please send an email to: salesaddresses@nxp.com

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